

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination MAEDA, PATRICK Y.	
		Examiner Hai C. Pham	Art Unit 2861	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,091,537	07-2000	Sun et al.	359/248
*	B	US-7,002,613	02-2006	Beier et al.	347/238
*	C	US-5,940,113	08-1999	Wilson, James M.	347/238
*	D	US-5,325,386	06-1994	Jewell et al.	372/50.124
*	E	US-5,745,152	04-1998	Vincent et al.	347/238
*	F	US-6,257,739	07-2001	Sun et al.	362/285
G	US-				
H	US-				
I	US-				
J	US-				
K	US-				
L	US-				
M	US-				

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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